

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/024,412	LEUNG ET AL.	
Examiner	Art Unit	
Duc M. Nguyen	2685	

	SEARCHED				
Class	Subclass	Date	Examiner		
455	72 410 412.1				
	466 414.2				
	433 266				
341	51				
	106				
704	10 230				
	500->504				
715	532				
709	247	2/2/2006	DN		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

RCH STRATEGY	<u>() </u>
DATE	EXMR
1/13/2006	DN
2/2/2006	DN
	1/13/2006